

Notice of References Cited	Application/Control No. 10/582,118		Applicant(s)/Patent Under Reexamination VOLLMANN ET AL.	
	Examiner Jack A. Lane		Art Unit 2185	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0168313	07-2007	Leroy et al.	707/001
*	B	US-7,467,376	12-2008	Le Metayer et al.	717/143
*	C	US-7,114,646	10-2006	Hillhouse, Robert D.	235/375
*	D	US-7,484,095	01-2009	de Jong, Eduard	713/170
*	E	US-7,506,175	03-2009	Baentsch et al.	713/187
*	F	US-7,478,367	01-2009	Morgan et al.	717/124
*	G	US-7,281,244	10-2007	de Jong, Eduard	717/168
*	H	US-7,281,244	10-2007	de Jong, Eduard	717/168
*	I	US-7,281,237	10-2007	de Jong, Eduard K.	717/126
*	J	US-7,272,839	09-2007	Moribe et al.	720/677
*	K	US-7,222,331	05-2007	de Jong, Eduard	717/106
*	L	US-7,165,246	01-2007	de Jong, Eduard	717/166
*	M	US-7,131,121	10-2006	Krishna et al.	717/165

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003323597 A	11-2003	Japan	YOSHIMOTO et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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